


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	09/922,178	LEWIS, CRAIG	
	Examiner	Art Unit	
	Minh Dieu Nguyen	2137	

SEARCHED			
Class	Subclass	Date	Examiner
713	184	2/9/2006	MDN
726	2, 6, 18	2/9/2006	MDN

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Updated inventor name search on EAST (US-PAT; US-PG-PUB; EPO; JPO; DERWENT; IBM-TDB)	2/9/2006	MDN
Updated text and class search on EAST (US-PAT; US-PG-PUB; EPO; JPO; DERWENT; IBM-TDB)	2/9/2006	MDN